

| INFORMATION DISCLOSURE STATEMENT BY APPLICANT | | | | <i>Complete if Known</i> | | | |
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| | | | | Application Number | | | |
| | | | | Filing Date | | | |
| | | | | First Named Inventor | | | |
| | | | | Group Art Unit | | | |
| | | | | Examiner Name | | | |
| Sheet | 1 | of | 2 | Attorney Docket Number | | | |
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code.

⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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| | | | | Filing Date | March 26, 2004 |
| | | | | First Named Inventor | BRYSON |
| | | | | Group Art Unit | 3681 |
| | | | | Examiner Name | D. Le |
| Sheet | 2 | of | 2 | Attorney Docket Number | 1110-279 |

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